

TRENCH Gen6 RTMOS

DIM800WHS12-PF500

Half Bridge IGBT Module

Replaces DS6406-1 DS6406-2 May 2023 (LN42575)

FEATURES

- Cu Base with Al₂O₃ Substrates
- High Thermal Cycling capacity
- High Power Density

APPLICATIONS

- Motor Drives
- High Power Converters
- Wind Turbines
- UPS Systems

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800WHS12-PF500 is a Half Bridge 1200V, trench gate, insulated gate bipolar transistor (IGBT) module with enhanced field stop and implantation technology. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 8µs short circuit withstand. This device is optimised for motor drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800WHS12-PF500

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}		1200V
V _{CE(sat)}	* (typ)	1.5V
Ic	(max)	800A
I _{C(PK)}	(max)	1600A

^{*} Measured at the auxiliary terminals

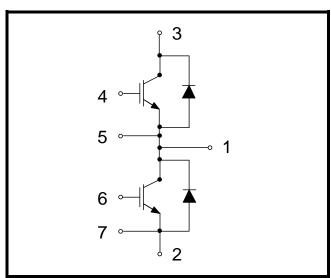


Fig. 1 Circuit configuration

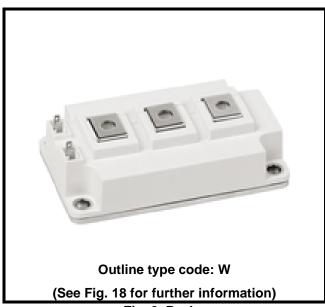


Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions		Units
Vces	Collector-emitter voltage	V _{GE} = 0V, T _C = 25°C	1200	V
V _{GES}	Gate-emitter voltage	T _C = 25°C	±20	V
Ic	Continuous collector current	Tc = 90°C, T _{vj} = 175°C	800	Α
I _{C(PK)}	Peak collector current	t _P = 1ms	1600	Α
P _{max}	Max. transistor power dissipation	Tc = 25°C, T _{vj} = 175°C	3.09	kW
l²t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_{vj} = 150$ °C	64.8	kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	4000	V

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Cu
Creepage distance – Terminal to heatsink:

Creepage distance – Terminal to terminal:

Clearance – Terminal to heatsink:

23mm
Clearance – Terminal to heatsink:

11mm
CTI (Comparative Tracking Index):

>400

Symbol	Parameter	Test Conditions		Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – IGBT	Continuous dissipation - junction to case		-	48.5	°C/kW
R _{th(j-c)}	Thermal resistance – diode			-	81.1	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (IGBT)	Mounting torque 3.5Nm (with mounting grease 1W/m °C)		22.6	-	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (Diode)			25.0	-	°C/kW
_	Junction temperature	IGBT	-40	-	150	°C
Tj		Diode	-40	-	150	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	3	-	6	Nm
		Electrical connections – M6	2.5		5	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
		V _{GE} = 0V, V _{CE} = V _{CES}				1	mA
I _{CES}	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES} , T _C = 125°C				10	mA
		VGE = 0V, VCE = VCES, TC =	150°C			20	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V				0.5	μΑ
V _{GE(TH)}	Gate threshold voltage	I _C = 20mA, V _{GE} = V _{CE}		5.3	5.9	6.5	V
		V _{GE} = 15V, I _C = 800A			1.50	1.90	V
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15V$, $I_C = 800A$, $T_j = 1$	125°C		1.70		V
	venage	$V_{GE} = 15V$, $I_C = 800A$, $T_j = 1$	150°C		1.75		V
l _F	Diode forward current	DC			800		Α
I _{FM}	Diode peak forward current	$t_p = 1 ms$			1600		Α
	Diode forward voltage	IF = 800A			1.65	2.05	V
VF		IF = 800A, Tj = 125°C			1.80		V
		IF = 800A, Tj = 150°C			1.80		V
Cies	Input capacitance	VCE = 25V, VGE = 0V, f = 100kHz			106		nF
Qg	Gate charge	±15V			6.4		μC
Cres	Reverse transfer capacitance	Vce = 25V, Vge = 0V, f = 10	0kHz		0.5		nF
L _{sCE}	Module inductance				20		nΗ
Rcc'+EE'	Module lead resistance, Terminal - chip	Per switch			0.4		mΩ
RINT	Internal transistor resistance				1.8		Ω
SCpate	Short circuit current, Isc	Vcc = 800V V _{GE} ≤ 15V	$T_j = 150^{\circ}C,$ $t_p \le 8\mu s,$		4100		А
SC _{Data}		$V_{CE (max)} = V_{CES} - L^* x di/dt$ IEC 60747-9	$T_j = 175$ °C, $t_p \le 6\mu$ s,		3900		Α

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time		<i>dv/dt</i> = 4000V/µs		840		ns
t f	Fall time				110		ns
Eoff	Turn-off energy loss				106.5		mJ
t _{d(on)}	Turn-on delay time		<i>di/dt</i> = 7300A/µs		400		ns
t _r	Rise time				100		ns
Eon	Turn-on energy loss				50		mJ
Qrr	Diode reverse recovery charge	I _F = 800A			77.5		μC
Irr	Diode reverse recovery current	V _{CE} = 600V		560		Α	
Erec	Diode reverse recovery energy	di/dt = 7	/300A/µs		42		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$\begin{array}{c} I_{C} = 800A \\ V_{CE} = 600V \\ V_{GE} = \pm 15V \\ R_{G(OFF)} = 3.3\Omega \\ R_{G(ON)} = 1.8\Omega \\ L_{S} \sim 45 nH \end{array}$	<i>dv/dt</i> = 4000V/μs		900		ns
t _f	Fall time				240		ns
E _{OFF}	Turn-off energy loss				137		mJ
t _{d(on)}	Turn-on delay time		di/dt = 7300A/µs		420		ns
tr	Rise time				110		ns
Eon	Turn-on energy loss				68		mJ
Qrr	Diode reverse recovery charge	I _F = 800A			134.5		μC
I _{rr}	Diode reverse recovery current	V _{CE} = 600V		760		Α	
Erec	Diode reverse recovery energy	<i>di/dt</i> = 7300A/μs			70		mJ

$T_{case} = 150$ °C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$\begin{array}{c} I_{C} = 800A \\ V_{CE} = 600V \\ V_{GE} = \pm 15V \\ R_{G(OFF)} = 3.3\Omega \\ R_{G(ON)} = 1.8\Omega \\ L_{S} \sim 45 nH \end{array}$	<i>dv/dt</i> = 4000V/μs		940		ns
t _f	Fall time				270		ns
E _{OFF}	Turn-off energy loss				142.5		mJ
t _{d(on)}	Turn-on delay time		<i>di/dt</i> = 7300A/µs		420		ns
t _r	Rise time				110		ns
Eon	Turn-on energy loss				79		mJ
Qrr	Diode reverse recovery charge	IF = 800A			151		μC
Irr	Diode reverse recovery current	$V_{CE} = 600V$		780		Α	
Erec	Diode reverse recovery energy	<i>di/dt</i> = 7300A/μs			79.6		mJ

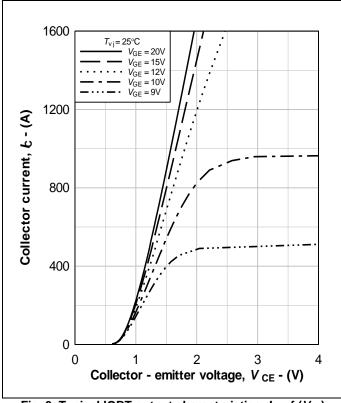


Fig. 3 Typical IGBT output characteristics, $I_C = f(V_{CE})$

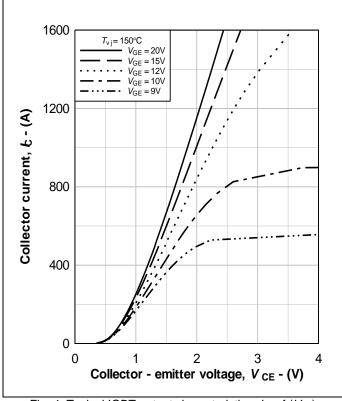


Fig. 4 Typical IGBT output characteristics, $I_C = f(V_{CE})$

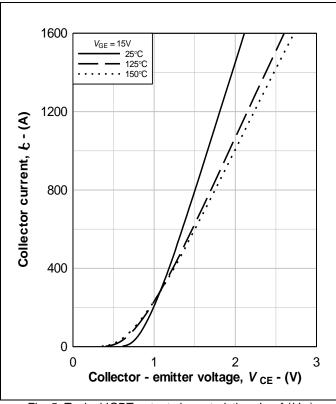


Fig. 5 Typical IGBT output characteristics, $I_C = f(V_{CE})$

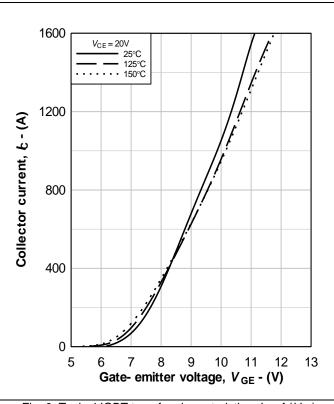


Fig. 6 Typical IGBT transfer characteristics, $I_C = f(V_{GE})$

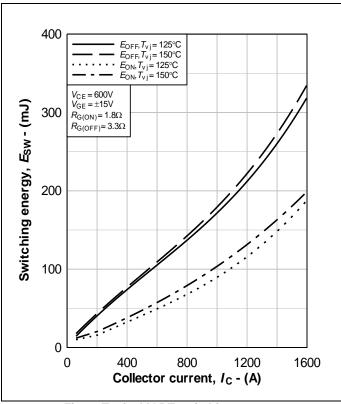


Fig. 7 Typical IGBT switching energy, $E_{ON} = f(I_C)$, $E_{OFF} = f(I_C)$

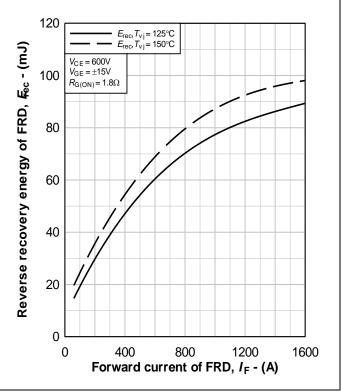


Fig. 9 Typical FRD E_{rec} , $E_{rec} = f(I_F)$

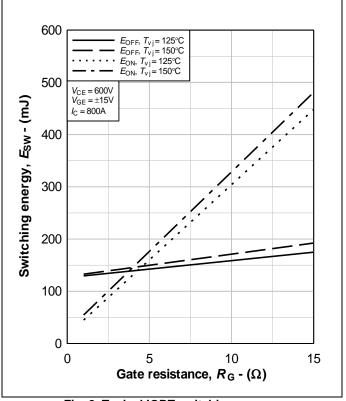


Fig. 8 Typical IGBT switching energy, $E_{ON} = f(R_G)$, $E_{OFF} = f(R_G)$

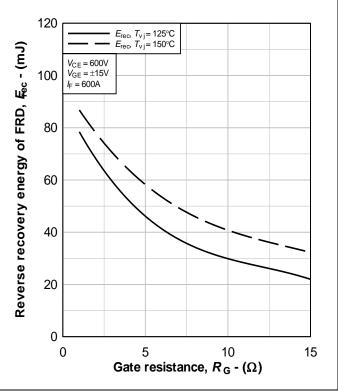


Fig. 10 Typical FRD E_{rec} , $E_{rec} = f(R_G)$

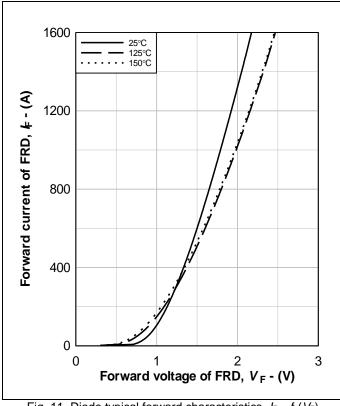


Fig. 11 Diode typical forward characteristics, $I_F = f(V_F)$

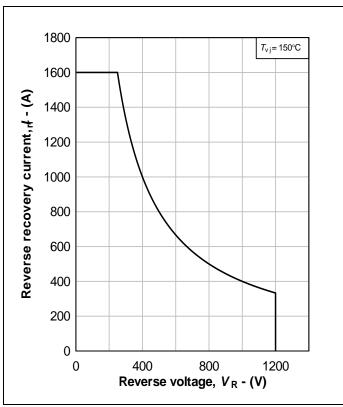


Fig. 13 Reverse bias safe operating area of FRD, $I_{rr} = f(V_R)$

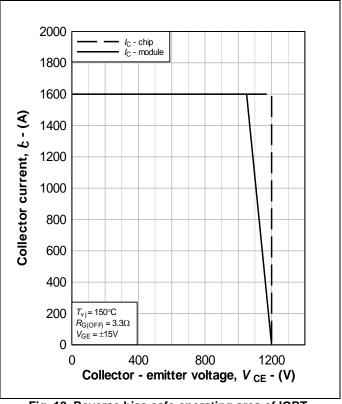


Fig. 12 Reverse bias safe operating area of IGBT, $I_C = f(V_{CE})$

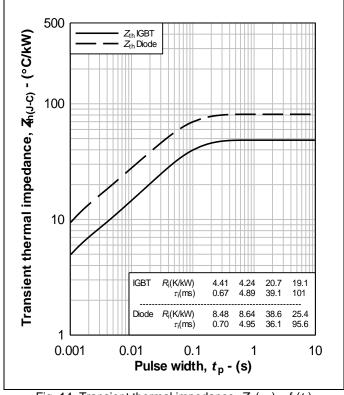


Fig. 14 Transient thermal impedance, $Z_{th}(J-C) = f(t_p)$

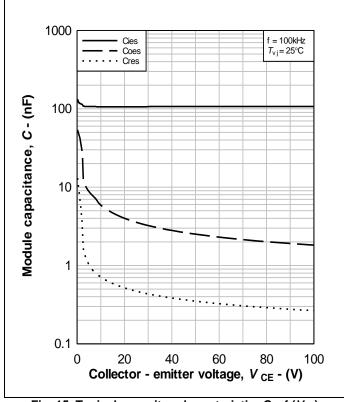


Fig. 15 Typical capacitor characteristic, $C = f(V_{CE})$

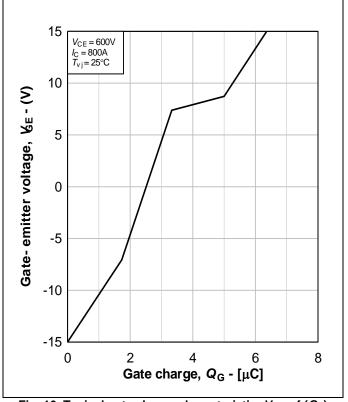


Fig. 16 Typical gate charge characteristic, $V_{GE} = f(Q_G)$

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

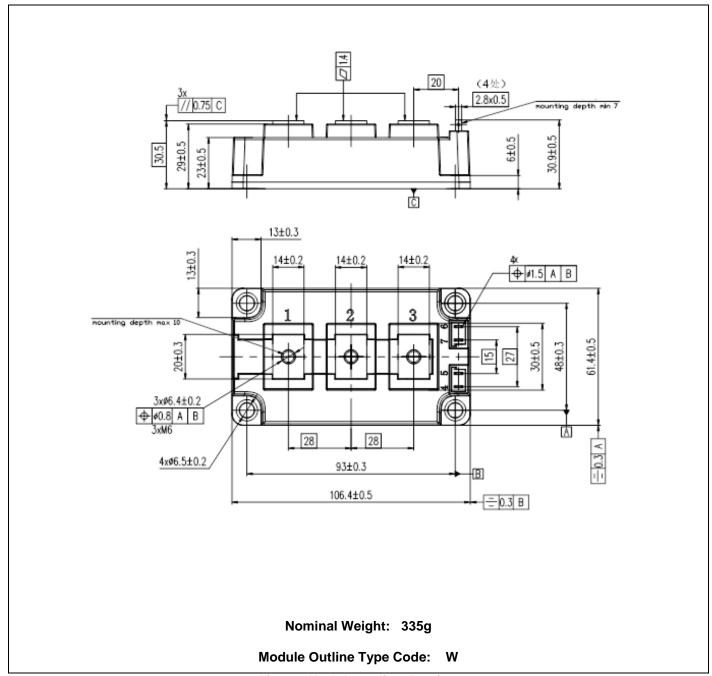


Fig. 17 Module outline drawing

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